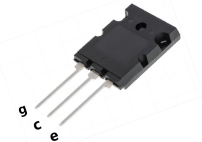
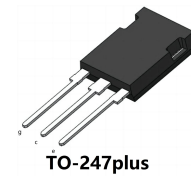


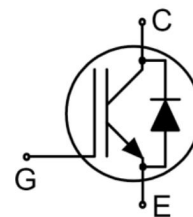
Features

- Very Low Saturation Voltage:
 $V_{CE(sat)} = 1.70V @ I_C = 200 A$
- Maximum Junction Temperature: $T_J = 175^{\circ}C$
- Positive Temperature Co-Efficient
- Tight Parameter Distribution
- High Input Impedance



Applications

- Traction Inverter for HEV/EV
- Auxiliary DC/AC Converter
- Motor Drives
- Other Power-Train Applications
Requiring High Power Switch



Absolute Ratings($T_c=25^{\circ}C$)

Parameter	Symbol	Value	Unit
Collector-Emitter Voltage	V_{ce}	650	V
Collector Current-continuous	I_C $T=25^{\circ}C$ $T=100^{\circ}C$	400	A
		200	A
Diode forward current	I_F $T=25^{\circ}C$ $T_c=100^{\circ}C$	400	A
		200	A
Collector Current-pulse (note 1)	I_{CM}	600	A
Gate-Emitter Voltage	V_{GES}	± 20	V
Power Dissipation(TO-264)	PD	625	W
Power Dissipation(TO-247Plus)	PD	882	W
Operating Temperature Range	T_J	-40~+175	$^{\circ}C$
Storage Temperature Range	T_{STG}	-55~+150	
Short Circuit Withstand Time(note 2)	t_{sc}	5	us
Maximum Lead Temperature for Soldering Purposes	T_L	260	$^{\circ}C$
Isolation Voltage for Case-Terminal	V_{ISO}	2.5	KV

Electrical Characteristics

Parameter	Symbol	Tests conditions	Min	Typ	Max	Units
Off-Characteristics						
Collector-Emitter Voltage	BV_{CES}	$I_C=1.6mA, V_{GE}=0V$	650	-	-	V
Zero Gate Voltage Collector Current	I_{CES}	$V_{CE}=650V, V_{GE}=0V, T_C=25^\circ C$	-	-	2	μA
Gate-body leakage current, forward	I_{GESF}	$V_{CE}=0V, V_{GE}=20V$	-	-	100	nA
Gate-body leakage current, reverse	I_{GESR}	$V_{CE}=0V, V_{GE}=-20V$	-	-	-100	nA
On-Characteristics						
Gate Threshold Voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}, I_C=250\mu A$	3.5	5.0	6.5	V
Collector-Emitter saturation Voltage	V_{CESAT}	$V_{GE}=15V, I_C=200A$	-	1.7	1.9	V
Dynamic Characteristics						
Input capacitance	C_{ies}	$V_{CE}=30V, V_{GE}=0V, f=1.0MHz$	-	5012	-	pF
Output capacitance	C_{oes}		-	430	-	pF
Reverse transfer capacitance	C_{res}		-	100	-	pF
Transconductance	g_{fs}	$I_C=60A, V_{CE}=10V$ (Note 3)	30	50	-	S
Short-circuit collector current	I_{SC}	$V_{CC} \leq 600V, V_{GE} = 15V, t_{SC} \leq 5\mu s$ (Note 4)	-	1200	-	A

Electrical Characteristics

Parameter	Symbol	Tests conditions	Min	Typ	Max	Units
Switching Characteristics						
Turn-on delay time	$t_{d(on)}$	$V_{CC}=400V, I_C=200A, R_G=4.7\Omega, V_{GE}=15V, Inductive Load, T_C=25^\circ C$	-	84	-	ns
Turn-On rise time	t_r		-	147	-	ns
Turn-Off delay time	$t_{d(off)}$		-	216	-	ns
Turn-Off Fall time	t_f		-	133	-	ns
Turn-on Loss	E_{on}		-	5.4	-	mJ
Turn-off Loss	E_{off}		-	3.8	-	mJ
Total Loss	E_{ts}		-	9.2	-	mJ
Turn-on delay time	$t_{d(on)}$	$V_{CC}=400V, I_C=200A, R_G=4.7\Omega, V_{GE}=15V,$	-	80	-	ns
Turn-On rise time	t_r		-	160	-	ns

Turn-Off delay time	$t_{d(off)}$	Inductive Load $T_c=150^{\circ}C$	-	244	-	ns
Turn-Off Fall time	t_f		-	166	-	ns
Turn-on switching Loss	E_{on}		-	9.7	-	mJ
Turn-off switching Loss	E_{off}		-	5.2	-	mJ
Total switching Loss	E_{ts}		-	14.9	-	mJ
Gate Charge	Q_g	$V_{CC}=400V, I_c=100A$ $V_{GE}=15V$	-	157	-	nC
Gate to Emitter Charge	Q_{ge}		-	43	-	nC
Gate to Collector Charge	Q_{gc}		-	64	-	nC
Anti-Parallel Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Voltage	V_F	$I_F=200A(T_J=25^{\circ}C)$	-	1.8	2.0	V
Diode Reverse recovery time	t_{rr}	$I_F=200A$ $di_F=dt=200A/us$ $T_J=25^{\circ}C$	-	62	-	ns
Diode Reverse recovery charge	Q_{rr}		-	164	-	nC

Thermal Characteristic

Parameter	Symbol	Max		Unit
		TO-247Plus	TO-264	
Thermal Resistance, Junction to Case (IGBT)	$R_{th(j-c)}$	0.2		$^{\circ}C/W$
Thermal Resistance, Junction to Case (Diode)	$R_{th(j-c)}$	0.4		$^{\circ}C/W$
Thermal Resistance, Junction to Ambient	$R_{th(j-A)}$	25		$^{\circ}C/W$

Notes:

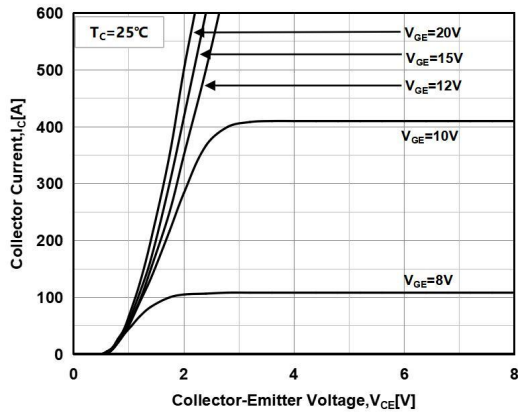
1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. $V_{GE}=15V, V_{CE}=360V, T_J=150^{\circ}C, R_G=10\Omega$, Non Repetitive
3. Switching times & energy losses may increase for higher $V_{CE}(clamp)$, T_J or R_G
4. Allowed number of short circuits < 1000, Time between short circuits ≥ 1.0 s

Order Information

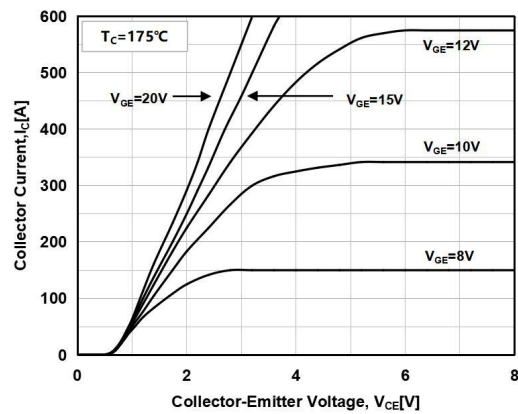
Type Specification	Packaging
MSG200T65HLC1	TO-247Plus
MSG200T65HLB3	TO-264

Electrical Characteristics (curves)

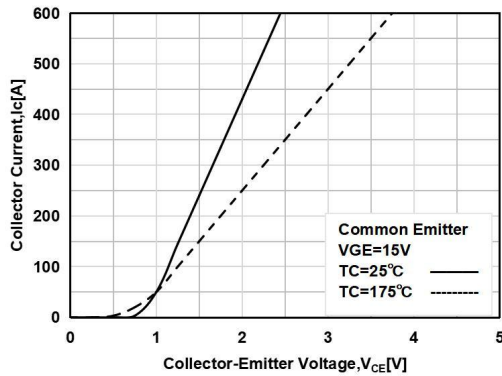
Typical Output Characteristics



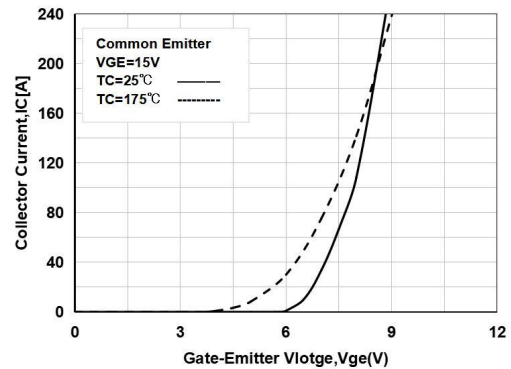
Typical Output Characteristics



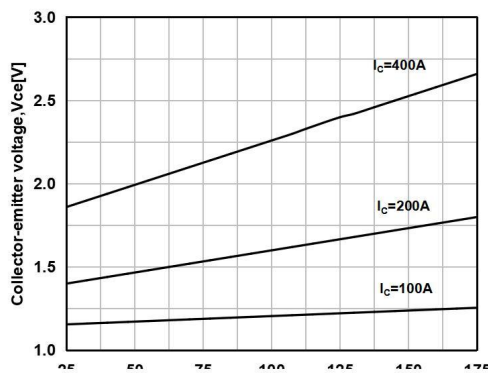
Typical Saturation Voltage Characteristics



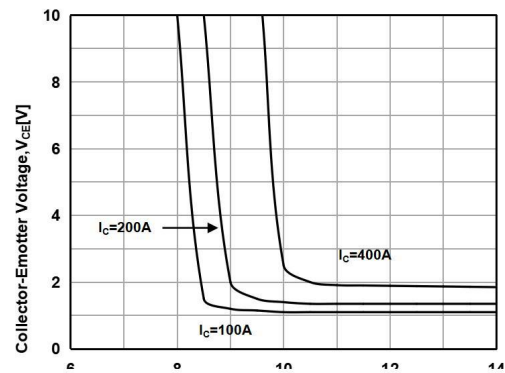
Transfer Characteristics



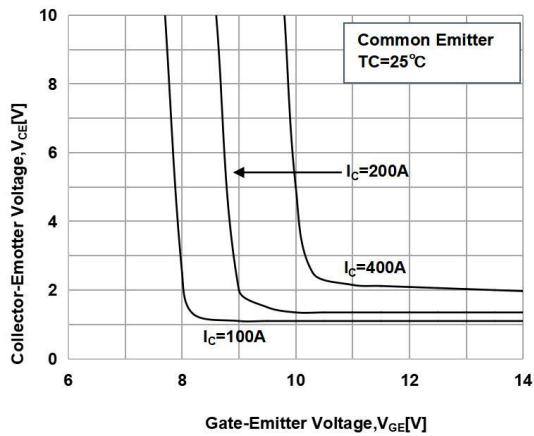
Saturation Voltage vs. Junction temperature at Variant Current Level



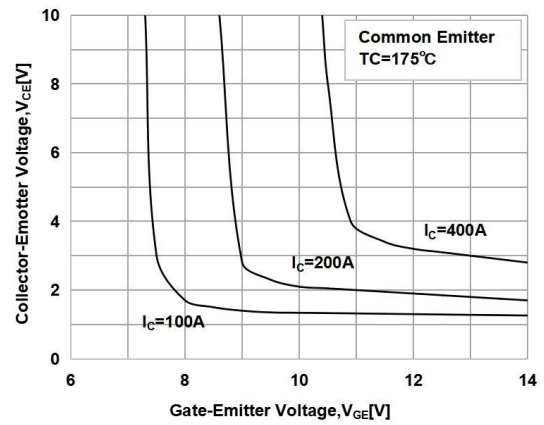
Saturation Voltage vs. V_{CE}



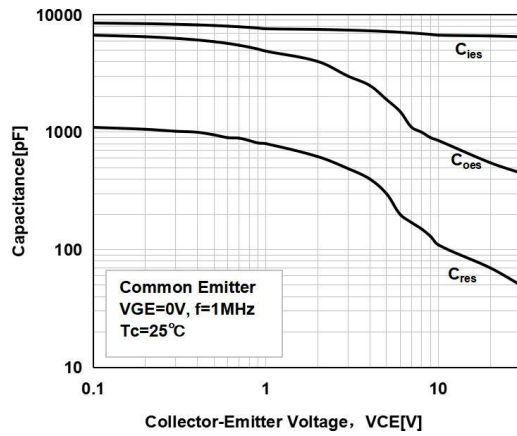
Saturation Voltage vs. V_{GE}



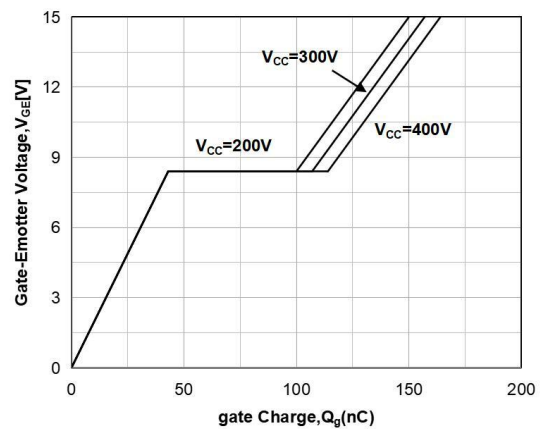
Saturation Voltage vs. V_{GE}



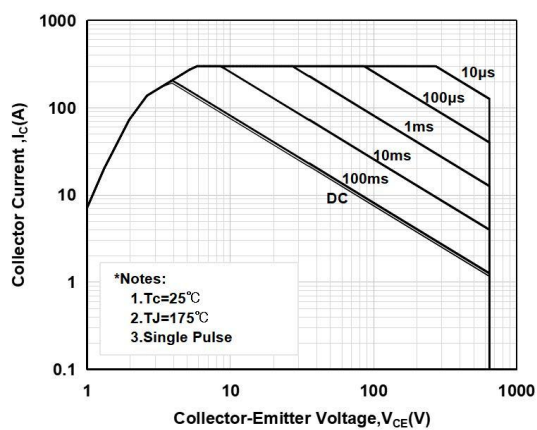
Capacitance Characteristics



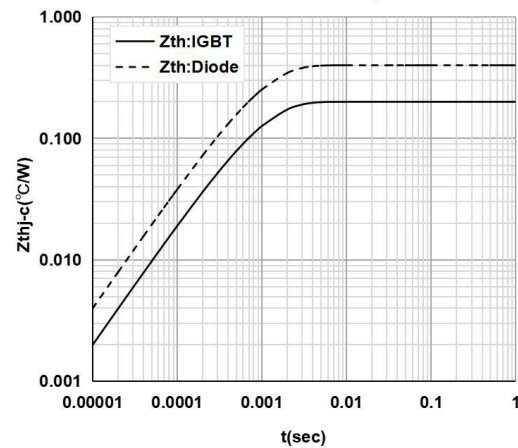
Gate Charge Characteristics



Foward Bias Safe Operating Area

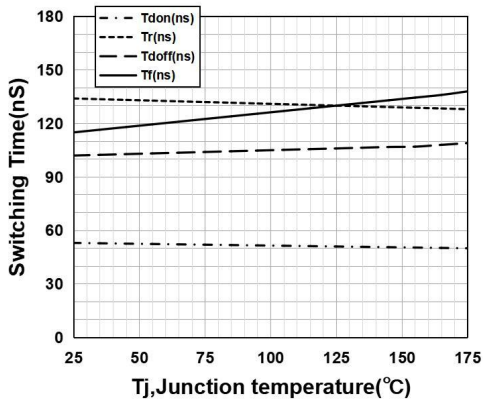


Transient Thermal Impedance



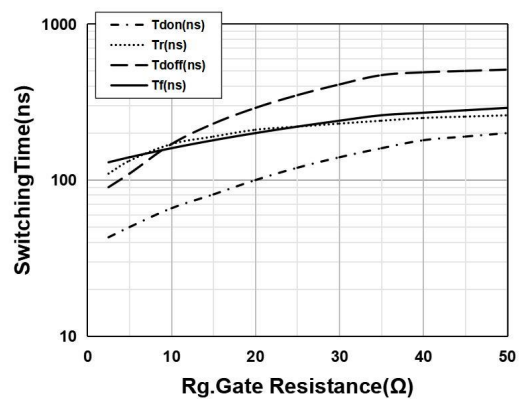
Switching Time vs. Tj

Vge=15V, Vce=400V, Ic=200A, Rg=5Ω



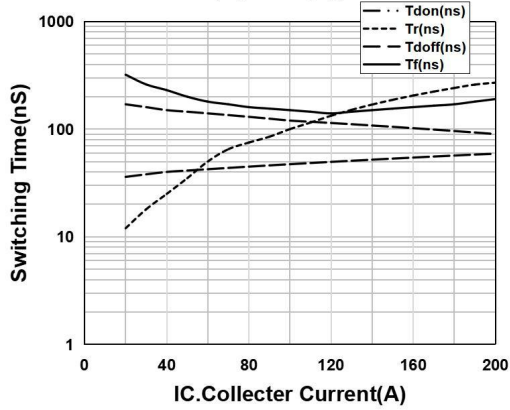
Switching Time Vs. Rg(175°C)

Vge=15V, Vce=400V, Ic=200A



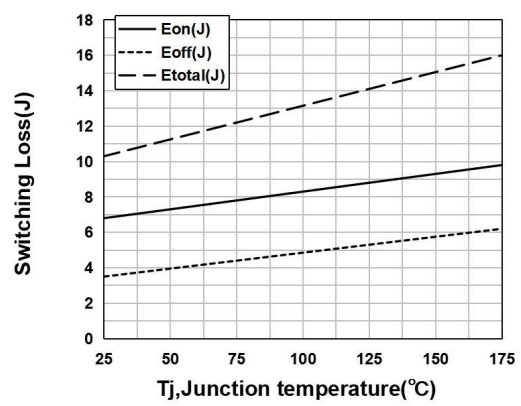
Switching Time vs. Ic(175°C)

Vce=400V, Vge=15V, Rg=5Ω



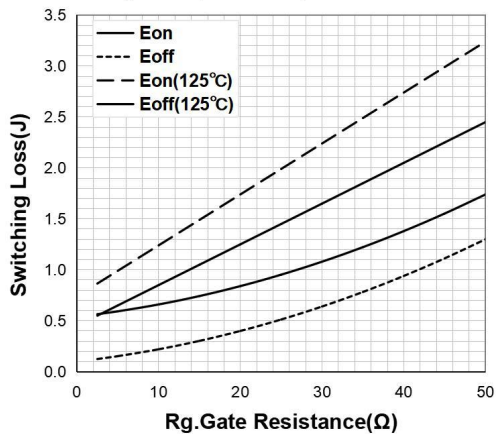
Switching Loss vs. Tj

Vge=15V, Vce=400V, Ic=200A, Rg=5Ω



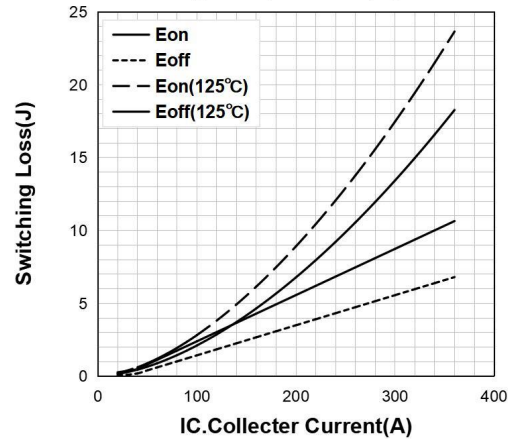
Switching Loss vs. Rg(175°C)

Vge=15V, Vce=400V, Ic=200A

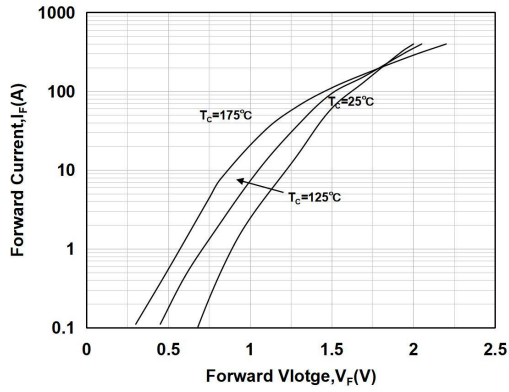


Switching Loss vs. Ic(175°C)

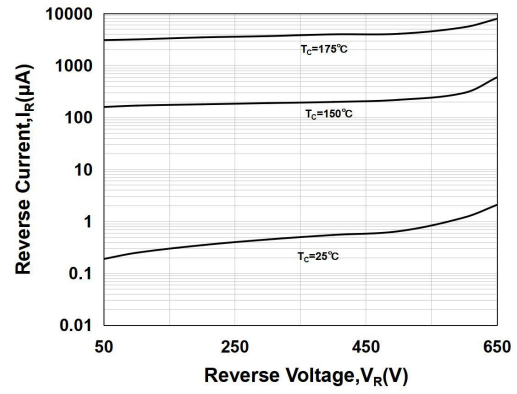
Vge=15V, Vce=400V, Rg=5Ω



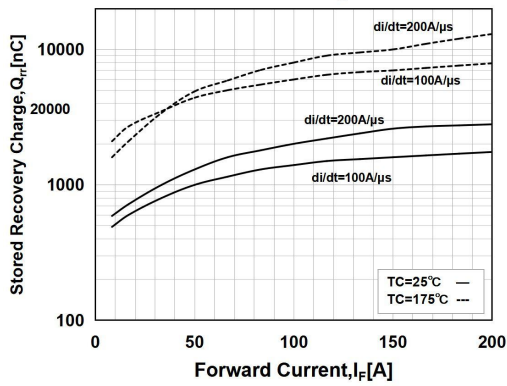
Forward Characteristics



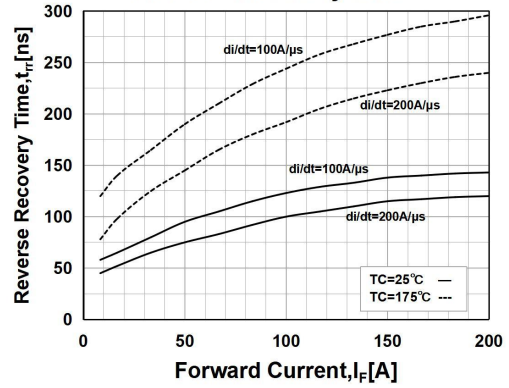
Reverse Current



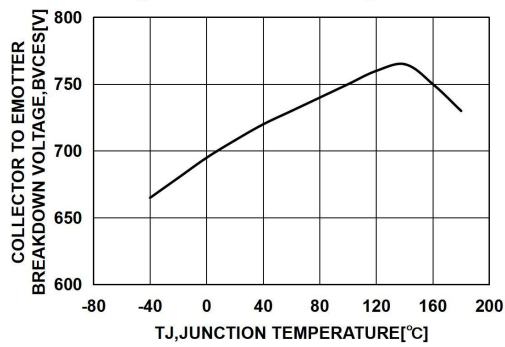
Stored Charge



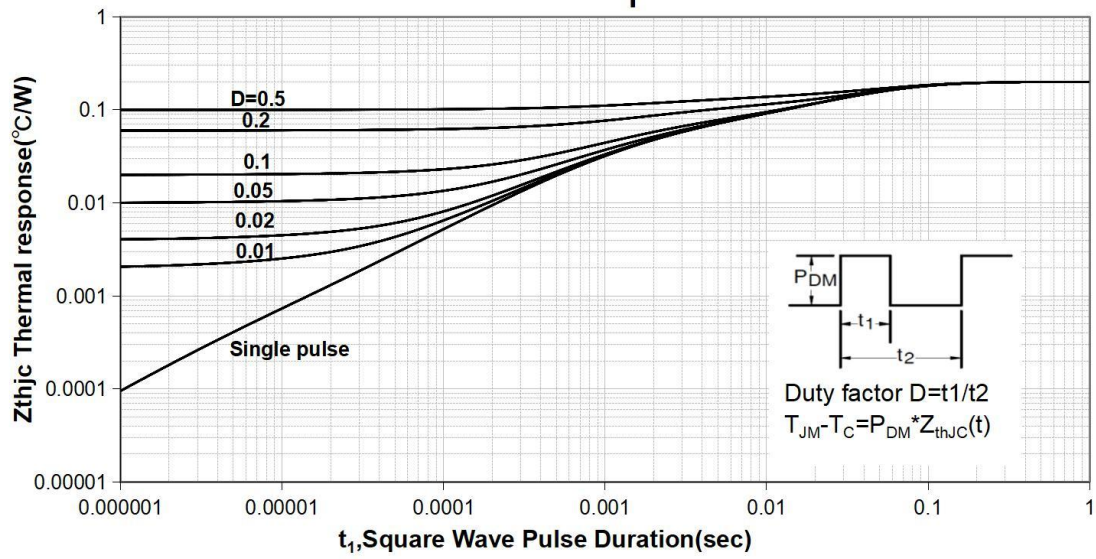
Reverse Recovery Time



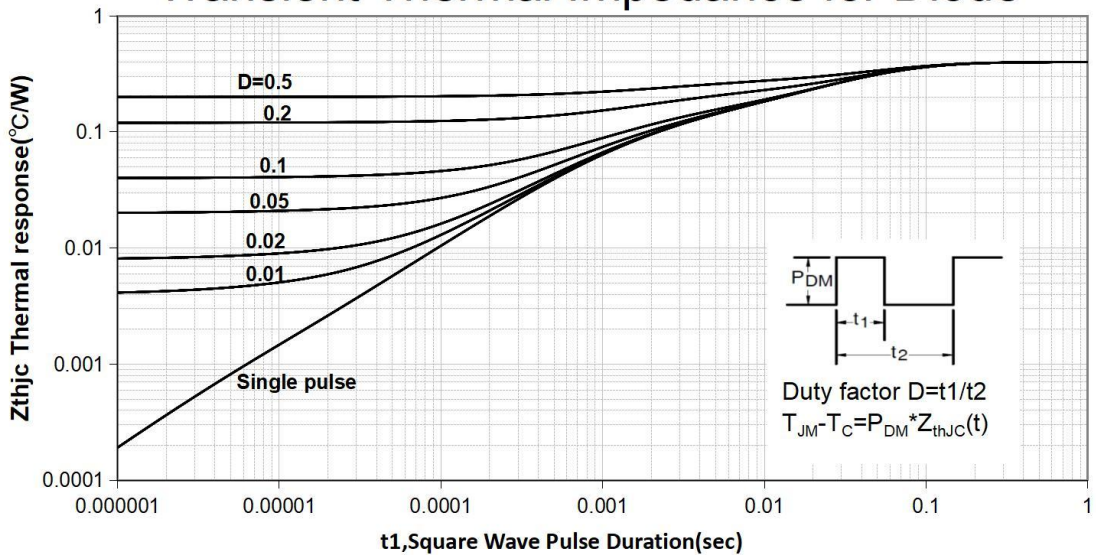
Collector to Emitter Breakdown Voltage vs. Junction Temperature



Transient Thermal Impedance for IGBT



Transient Thermal Impedance for Diode



Package Mechanical DATA

